

UTC UNISONIC TECHNOLOGIES CO., LTD

13NM95-Q **Preliminary Power MOSFET**

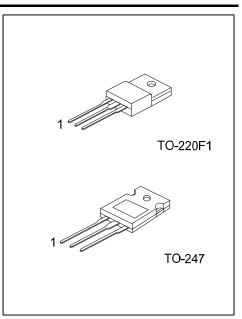
13A, 950V N-CHANNEL SUPER-JUNCTION MOSFET

DESCRIPTION

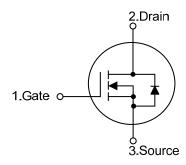
The UTC 13NM95-Q is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and a high rugged avalanche characteristics. This power MOSFET is usually used at AC-DC converters for power applications.

FEATURES

- * $R_{DS(ON)} \le 0.66 \Omega$ @ V_{GS} =10V, I_D =6.5A
- * Fast switching capability
- * Avalanche energy tested
- * Improved dv/dt capability, high ruggedness



SYMBOL



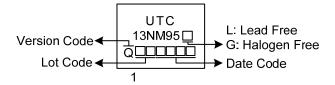
ORDERING INFORMATION

Ordering Number		Daakana	Pin Assignment			Daakina	
Lead Free	Halogen Free	Package	1	2	3	Packing	
13NM95L-Q-TF1-T	13NM95G-Q-TF1-T	TO-220F1	G	D	S	Tube	
13NM95L-Q-T47-T	13NM95G-Q-T47-T	TO-247	G	D	S	Tube	

S: Source Note: Pin Assignment: G: Gate D: Drain 13NM95G-Q-TF1-T (1) T: Tube - (1)Packing Type (2) TF1: TO-220F1, T47: TO-247 (2)Package Type (3) Version Q (3)Version Code (4)Green Package (4) G: Halogen Free and Lead Free, L: Lead Free

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■ MARKING



■ **ABSOLUTE MAXIMUM RATINGS** (T_C=25°C, unless otherwise specified)

PARAMETER			SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V _{DSS}	950	V	
Gate-Source Voltage			V _{GSS}	±30	V
Drain Current	Cantinuaua	T _C =25°C	Ι _D	13	Α
	Continuous	T _C =100°C		8.4	Α
	Pulsed (Note	Pulsed (Note 2)		39	Α
Avalanche Energy	Single Pulsed	Single Pulsed (Note 3)		420	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	1.3	V/ns	
Power Dissipation		P _D	23	W	
Junction Temperature		TJ	+150	°C	
Storage Temperature		T _{STG}	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 100mH, I_{AS} = 2.9A, V_{DD} = 90V, R_G = 25 Ω , Starting T_J = 25°C
- 4. $I_{SD} \leq 13A$, di/dt $\leq 200A/\mu s$, $V_{DD} \leq BV_{DSS}$, Starting T_J = 25°C

■ THERMAL DATA

PARAMETER	SYMBOL	RATING	UNIT	
Junction to Ambient	θЈΑ	62.5	°C/W	
Junction to Case	θις	5.4	°C/W	

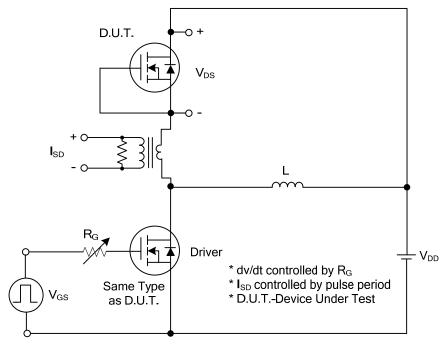
■ **ELECTRICAL CHARACTERISTICS** (T_J=25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage	BV_DSS	$V_{GS}=0V$, $I_D=250\mu A$	950			V		
Drain-Source Leakage Current	I_{DSS}	V _{DS} =950V, V _{GS} =0V			10	μΑ		
Gate-Source Leakage Current	I_{GSS}	$V_{GS}=\pm30V$, $V_{DS}=0V$			±100	nA		
ON CHARACTERISTICS								
Gate Threshold Voltage	Threshold Voltage V _{GS(TH)}		2.5		4.5	V		
Static Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =6.5A			0.66	Ω		
DYNAMIC CHARACTERISTICS								
Input Capacitance	C _{ISS}			970		рF		
Output Capacitance	Coss	V _{GS} =0V, V _{DS} =50V, f=1MHz		93		рF		
Reverse Transfer Capacitance	C _{RSS}	7		3.5		рF		
SWITCHING CHARACTERISTICS								
Total Gate Charge	Q_{G}	700// // 40// 1 404		57		nC		
Gate-Source Charge	Q _{GS}	V _{DS} =760V, V _{GS} =10V, I _D =13A		14		nC		
Gate-Drain Charge	Q_{DD}	(Note 1, 2)		25		nC		
Turn-On Delay Time	t _{D(ON)}			8		ns		
Turn-On Rise Time	t _R	V _{DD} =100V, V _{GS} =10V, I _D =13A,		19		ns		
Turn-Off Delay Time	t _{D(OFF)}	R _G =25Ω (Note 1, 2)		45		ns		
Turn-Off Fall Time	t⊧]		21		ns		
SOURCE- DRAIN DIODE RATINGS AND C	HARACTERI	STICS			_			
Maximum Continuous Drain-Source Diode	1-				13			
Forward Current	Is				13	Α		
Maximum Pulsed Drain-Source Diode	I _{SM}				39	Α		
Forward Current	ISM				39	^		
Drain-Source Diode Forward Voltage	V _{SD}	I _S =13A, V _{GS} =0V			1.4	V		
Body Diode Reverse Recovery Time	trr	I _S =13A, V _{GS} =0V,		600		nS		
Body Diode Reverse Recovery Charge	Qrr	dl _F /dt=100A/µs		10.5		μC		
N. 4 D. T. (D.)								

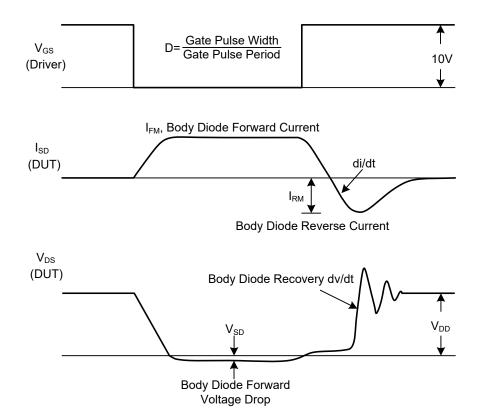
Notes: 1. Pulse Test: Pulse width \leq 300 μ s, Duty cycle \leq 2%.

^{2.} Essentially independent of operating temperature.

TEST CIRCUITS AND WAVEFORMS

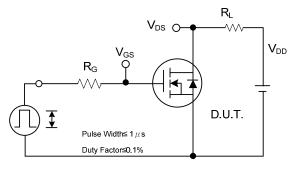


Peak Diode Recovery dv/dt Test Circuit

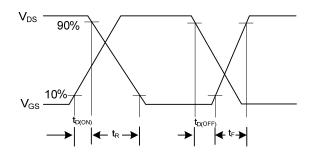


Peak Diode Recovery dv/dt Waveforms

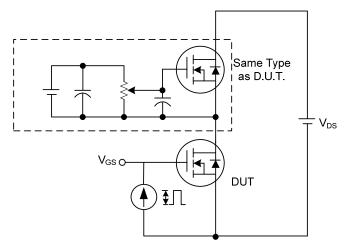
■ TEST CIRCUITS AND WAVEFORMS



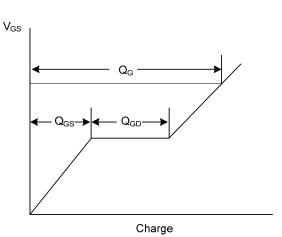
Switching Test Circuit



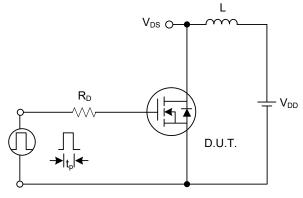
Switching Waveforms



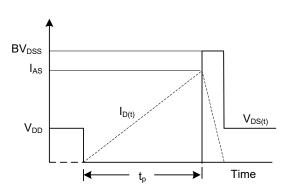
Gate Charge Test Circuit



Gate Charge Waveform



Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

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